

Notice of References Cited	Application/Control No. 10/659,642		Applicant(s)/Patent Under Reexamination TERRIEN ET AL.	
	Examiner MICHAEL D. PHAM		Art Unit 2167	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0021566	01-2005	Mu, Yuedong	707/200
*	B	US-6,587,217	07-2003	Lahey et al.	358/1.15
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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